

Search Notes

Application/Control No.

10/804,321

Examiner

John B. Nguyen

Applicant(s)/Patent under
Reexamination

BHARDWAJ ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	13,14	4/27/2005	JN
333	331, 239		
333	108,344		
398	101,178		
1	157,131		
398	123,164	4/27/2005	JN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
398	131	4/27/2005	JN
359	344	4/27/2005	JN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text serach	4/21/2005	JN